

N-Channel Super Junction Power MOSFET $\, \mathrm{I\!V} \,$

General Description

The series of devices use advanced trench gate super junction technology and design to provide excellent Rds(ON) with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

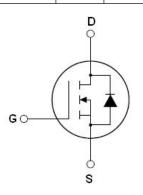
Features

- Optimized body diode reverse recovery performance
- ●Low on-resistance and low conduction losses
- Small package
- ●Ultra Low Gate Charge cause lower driving requirements
- ●100% Avalanche Tested
- ROHS compliant

Application

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)
- LLC Half-bridge

V _{DS min@Tjmax}	710	V
R _{DS(ON)TYP}	165	mΩ
ID	18	Α
Qg	30	nC



Schematic diagram

♦ Intrinsic fast-recovery body diode

Package Marking And Ordering Information

Device	Device Package	Marking
NCE65NF190F	TO-220F	NCE65NF190F



Table 1. Absolute Maximum Ratings (T_c=25℃)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (VGS=0V)	V _{DS}	650	V
Gate-Source Voltage (VDS=0V) AC (f>1 Hz)	Vgs	±30	V
Gate-Source Voltage (VDS=0V) DC	Vgs	±20	V
Continuous Drain Current at Tc=25°C	I _{D (DC)}	18	Α
Continuous Drain Current at Tc=100°C	I _{D (DC)}	12.6	Α
Pulsed drain current (Note 1)	I _{DM} (pluse)	54	Α
Maximum Power Dissipation(Tc=25°C)	P _D	33.9	W
Derate above 25°C		0.22	w/°C
Avalanche current ^(Note 1)	I _{AS}	4	Α
Drain Source voltage slope, V _{DS} ≤480 V,	dv/dt	50	V/ns
Reverse diode dv/dt, V _{DS} ≤480 V,I _{SD} <i<sub>D</i<sub>	dv/dt	50	V/ns
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55+175	°C

^{*} limited by maximum junction temperature



Table 2. Thermal Characteristic

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R _{thJC}	4.42	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R _{thJA}	62	°C /W

 Table 3. Electrical Characteristics (TA=25℃unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states	'			•	•	
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	650			V
Zero Gate Voltage Drain Current(Tc=25℃)	I _{DSS}	V _{DS} =650V,V _{GS} =0V			10	μA
Zero Gate Voltage Drain Current(Tc=125℃)	I _{DSS}	V _{DS} =650V,V _{GS} =0V			300	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250µA	3.5	4.2	5.0	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =9A		165	190	mΩ
Dynamic Characteristics						
Input Capacitance	C _{lss}	V 50VVV 0V		1550	1950	pF
Output Capacitance	Coss	V_{DS} =50V, V_{GS} =0V,		60		pF
Reverse Transfer Capacitance	C _{rss}	F=1.0MHz		5		pF
Total Gate Charge	Qg			30		nC
Gate-Source Charge	Qgs	V_{DS} =480 V , I_{D} =9 A ,		12.5		nC
Gate-Drain Charge	Q_{gd}	V _{GS} =10V		11		nC
Gate plateau voltage	Vgp			7.5		V
Intrinsic gate resistance	R _G	f = 1 MHz open drain		1.5		Ω
Switching times	•					
Turn-on Delay Time	t _{d(on)}			43		nS
Turn-on Rise Time	t _r	V_{DD} =380 V , I_{D} =9 A ,		17		nS
Turn-Off Delay Time	$t_{d(off)}$	$R_G=1.7\Omega, V_{GS}=10V$		94		nS
Turn-Off Fall Time	t _f			26		nS
Source- Drain Diode Characteristics	'			•	•	
Source-drain current(Body Diode)	I _{SD}	T 05%0			18	Α
Pulsed Source-drain current(Body Diode)	I _{SDM}	T _C =25°C			54	Α
Forward On Voltage	V _{SD}	Tj=25°C,I _{SD} =18A,V _{GS} =0V		0.9	1.2	V
Reverse Recovery Time	t _{rr}	T: 05°C ! 04		125		nS
Reverse Recovery Charge	Qrr	Tj=25°C,I _F =9A,		0.51		uC
Peak Reverse Recovery Current	I _{rrm}	di/dt=100A/μs		8.2		Α

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

^{2.} Tj=25 $^{\circ}\text{C}$,VDD=50V,VG=10V, RG=25 Ω



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

Figure 1. Safe operating area

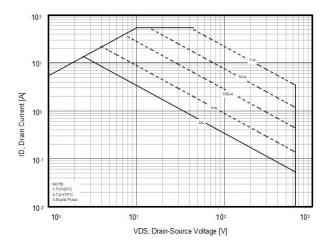


Figure 3. Transfer characteristics

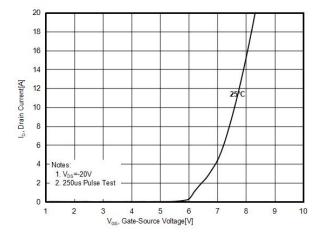


Figure 5. R_{DS(ON)} vs Junction Temperature

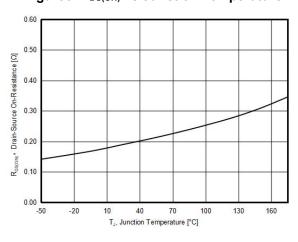


Figure 2. Capacitance

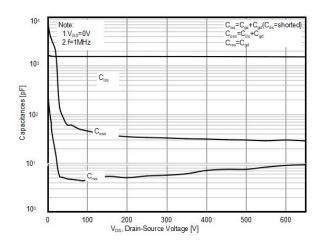


Figure 4. Output characteristics

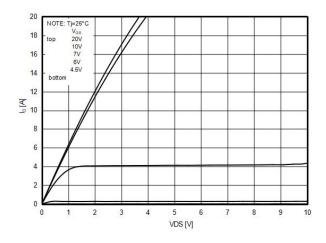


Figure 6. BV_{DSS} vs Junction Temperature

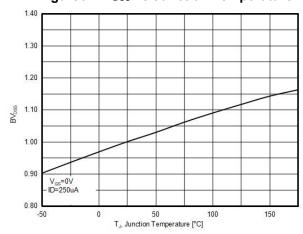




Figure 7. Maximum I_D vs Junction Temperature

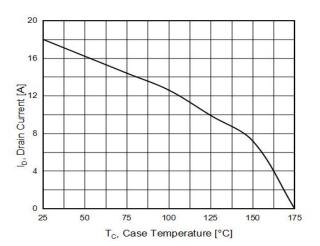


Figure8. Gate charge waveforms

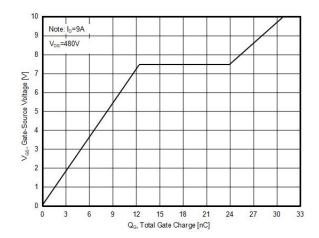


Figure 9. Static drain-source on resistance

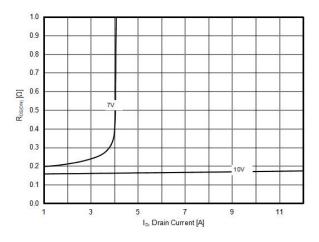
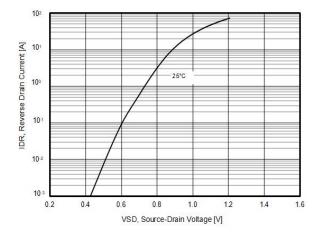


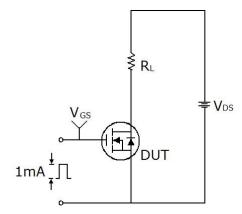
Figure 10. Source-Drain Diode Forward Voltage

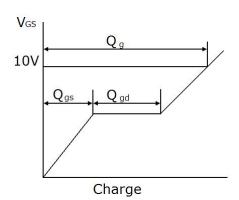




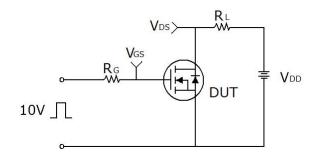
Test circuit

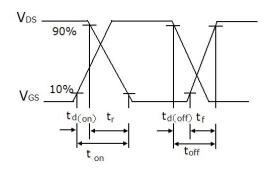
1) Gate charge test circuit & Waveform



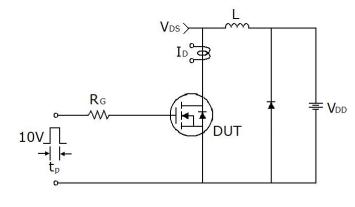


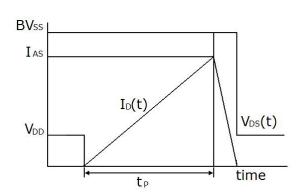
2) Switch Time Test Circuit:





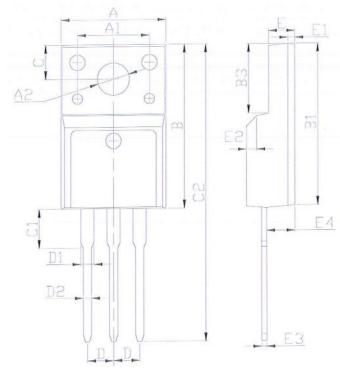
3) Unclamped Inductive Switching Test Circuit & Waveforms







TO-220F-L Package Information

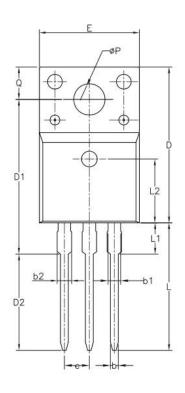


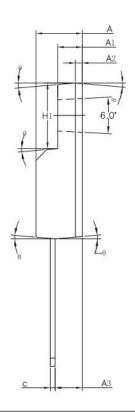
Symbol	Dimensions In Millimeters		Dimension	s In Inches
	Min.	Max.	Min.	Max.
A	9.86	10.46	0.387	0.411
A1	6.80	7.20	0.267	0.283
A3	9.40	10.00	0.369	0.393
В	15.40	16.40	0.605	0.644
B1	15.10	16.10	0.593	0.633
B2	4.40	5.00	0.173	0.196
B3	6.40	7.00	0.251	0.275
С	3.05	3.55	0.120	0.139
C1	2.95	3.55	0.116	0.139
C2	28.20	29.20	1.108	1.147
D	2.54	2.54 BSC		BSC
D1		1.47		0.058
D2	0.60	1.00	0.024	0.039
E	2.30	2.80	0.090	0.110
E1	0.45	0.95	0.018	0.037
E3	0.30	0.70	0.012	0.028
E4	2.45	3.05	0.096	0.120

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TO-220F-P Package Information





Symbol	Dimensions	Dimensions In Millimeters		s In Inches
	Min.	Max.	Min.	Max.
А	4.50	4.83	0.177	0.190
A1	2.34	2.74	0.092	0.108
A2	0.7	0 REF	0.028 REF	
A3	2.56	2.93	0.101	0.115
b	0.70	0.90	0.028	0.035
b1	1.18	1.38	0.046	0.054
b2		1.47		0.058
С	0.45	0.60	0.018	0.024
D	15.67	16.07	0.616	0.631
D1	15.55	15.95	0.611	0.627
D2	9.60	10.00	0.377	0.393
E	9.96	10.36	0.391	0.407
е	2.5	2.54 BSC) BSC
H1	6.48	6.88	0.255	0.270
L	12.68	13.28	0.498	0.522
L1		3.50		0.138
L2	6.5	6.50 REF		REF
Q	3.20	3.40	0.126	0.134



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